Application/Control No. Applicant(s)/Patent Under Reexamination 09/689,680 EEROLA ET AL. Notice of References Cited Examiner **Art Unit** Page 1 of 1 **Emmanuel Bayard** 2611 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-6,208,685 03-2001 Yamazaki, Hiroshi Α 375/152 * US-6,289,041 В 09-2001 Krasner, Norman F. 375/152 С US-6,650,689 11-2003 Oishi et al. 375/142 US-D US-Ε US-F US-G US-Н US-US-J Κ US-US-US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Country Code-Number-Kind Code MM-YYYY Classification Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS**

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